



# THE DATASHEET OF BSP171P

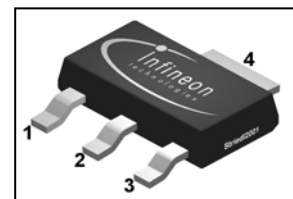


**SIPMOS<sup>®</sup> Small-Signal-Transistor**
**Features**

- P-Channel
- Enhancement mode
- Logic level
- Avalanche rated
- dv/dt rated
- Pb-free lead plating; RoHS compliant
- Qualified according to AEC Q101
- Halogen-free according to IEC61249-2-21

**Product Summary**

|                  |      |          |
|------------------|------|----------|
| $V_{DS}$         | -60  | V        |
| $R_{DS(on),max}$ | 0.3  | $\Omega$ |
| $I_D$            | -1.9 | A        |


**PG-SOT223**


| Type    | Package   | Tape and Reel Information | Marking | Packaging |
|---------|-----------|---------------------------|---------|-----------|
| BSP171P | PG-SOT223 | H6327: 1000 pcs/reel      | BSP171P | Non dry   |

**Maximum ratings, at  $T_j=25\text{ }^\circ\text{C}$ , unless otherwise specified**

| Parameter                           | Symbol         | Conditions   | Value        | Unit              |
|-------------------------------------|----------------|--|--------------|-------------------|
|                                     |                |  | steady state |                   |
| Continuous drain current            | $I_D$          | $T_A=25\text{ }^\circ\text{C}^{1)}$  | -1.9         | A                 |
|                                     |                | $T_A=70\text{ }^\circ\text{C}^{1)}$  | -1.5         |                   |
|                                     |                | $T_A=25\text{ }^\circ\text{C}$   | -7.6         |                   |
| Pulsed drain current                | $I_{D,pulse}$  | $T_A=25\text{ }^\circ\text{C}$   | -7.6         |                   |
| Avalanche energy, single pulse      | $E_{AS}$       | $I_D=-1.9\text{ A}, R_{GS}=25\ \Omega$   | 70           | mJ                |
| Reverse diode dv/dt                 | dv/dt          | $I_D=-1.9\text{ A}, V_{DS}=-48\text{ V}, di/dt=-200\text{ A}/\mu\text{s}, T_{j,max}=150\text{ }^\circ\text{C}$ | -6           | kV/ $\mu\text{s}$ |
| Gate source voltage                 | $V_{GS}$       |  | $\pm 20$     | V                 |
| Power dissipation                   | $P_{tot}$      | $T_A=25\text{ }^\circ\text{C}^{1)}$  | 1.8          | W                 |
| Operating and storage temperature   | $T_j, T_{stg}$ |  | -55 ... 150  | $^\circ\text{C}$  |
| IEC climatic category; DIN IEC 68-1 |                |  | 55/150/56    |                   |

ESD Class; JESD22-A114-HBM

Class 1a

| Parameter | Symbol | Conditions | Values |      |      | Unit |
|-----------|--------|------------|--------|------|------|------|
|           |        |            | min.   | typ. | max. |      |

**Thermal characteristics**

|  |            |   |   |   |     |     |
|--|------------|---|---|---|-----|-----|
| Thermal resistance, junction - soldering point | $R_{thJS}$ |   | - | - | 25  | K/W |
| Thermal resistance, junction - ambient         | $R_{thJA}$ | minimal footprint, steady state                             | - | - | 110 |     |
|  |            | 6 cm <sup>2</sup> cooling area <sup>1)</sup> , steady state | - | - | 70  |     |

**Electrical characteristics, at  $T_j=25\text{ }^\circ\text{C}$ , unless otherwise specified**
**Static characteristics**

|                                  |               |  |     |      |      |               |
|----------------------------------|---------------|--|-----|------|------|---------------|
| Drain-source breakdown voltage   | $V_{(BR)DSS}$ | $V_{GS}=0\text{ V}$ , $I_D=-250\text{ }\mu\text{A}$                              | -60 | -    | -    | V             |
| Gate threshold voltage           | $V_{GS(th)}$  | $V_{DS}=V_{GS}$ ,<br>$I_D=-460\text{ }\mu\text{A}$                               | -1  | -1.5 | -2   |               |
| Zero gate voltage drain current  | $I_{DSS}$     | $V_{DS}=-60\text{ V}$ , $V_{GS}=0\text{ V}$ ,<br>$T_j=25\text{ }^\circ\text{C}$  | -   | -0.1 | -1   | $\mu\text{A}$ |
|                                  |               | $V_{DS}=-60\text{ V}$ , $V_{GS}=0\text{ V}$ ,<br>$T_j=125\text{ }^\circ\text{C}$ | -   | -10  | -100 |               |
| Gate-source leakage current      | $I_{GSS}$     | $V_{GS}=-20\text{ V}$ , $V_{DS}=0\text{ V}$                                      | -   | -10  | -100 | nA            |
| Drain-source on-state resistance | $R_{DS(on)}$  | $V_{GS}=-4.5\text{ V}$ ,<br>$I_D=-1.5\text{ A}$                                  | -   | 0.3  | 0.45 | $\Omega$      |
|                                  |               | $V_{GS}=-10\text{ V}$ ,<br>$I_D=-1.9\text{ A}$                                   | -   | 0.21 | 0.3  |               |
| Transconductance                 | $g_{fs}$      | $ V_{DS} >2 I_D R_{DS(on)max}$ ,<br>$I_D=-1.5\text{ A}$                          | 1.4 | 2.7  | -    | S             |

<sup>1)</sup> Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm<sup>2</sup> (one layer, 70  $\mu\text{m}$  thick) copper area for drain connection. PCB is vertical in still air.

| Parameter | Symbol | Conditions | Values |      |      | Unit |
|-----------|--------|------------|--------|------|------|------|
|           |        |            | min.   | typ. | max. |      |

**Dynamic characteristics**

|                              |              |   |   |     |     |    |
|------------------------------|--------------|---|---|-----|-----|----|
| Input capacitance            | $C_{iss}$    | $V_{GS}=0\text{ V}$ ,<br>$V_{DS}=-25\text{ V}$ , $f=1\text{ MHz}$                           | - | 365 | 460 | pF |
| Output capacitance           | $C_{oss}$    |   | - | 105 | 135 |    |
| Reverse transfer capacitance | $C_{rss}$    |   | - | 40  | 55  |    |
| Turn-on delay time           | $t_{d(on)}$  | $V_{DD}=-25\text{ V}$ ,<br>$V_{GS}=-10\text{ V}$ ,<br>$I_D=-1.9\text{ A}$ , $R_G=6\ \Omega$ | - | 6   | 8   | ns |
| Rise time                    | $t_r$        |   | - | 25  | 33  |    |
| Turn-off delay time          | $t_{d(off)}$ |   | - | 208 | 276 |    |
| Fall time                    | $t_f$        |   | - | 87  | 130 |    |

**Gate Charge Characteristics<sup>2)</sup>**

|                       |               |   |   |      |      |    |
|-----------------------|---------------|---|---|------|------|----|
| Gate to source charge | $Q_{gs}$      | $V_{DD}=-48\text{ V}$ , $I_D=1.9\text{ A}$ ,<br>$V_{GS}=0\text{ to }-10\text{ V}$ | - | -1.2 | -1.6 | nC |
| Gate to drain charge  | $Q_{gd}$      |   | - | -5   | -7   |    |
| Gate charge total     | $Q_g$         |   | - | -13  | -20  |    |
| Gate plateau voltage  | $V_{plateau}$ |   | - | -3   | -    | V  |
| Output charge         | $Q_{oss}$     | $V_{DD}=-15\text{ V}$ , $V_{GS}=0\text{ V}$                                       | - | -5   | -7   |    |

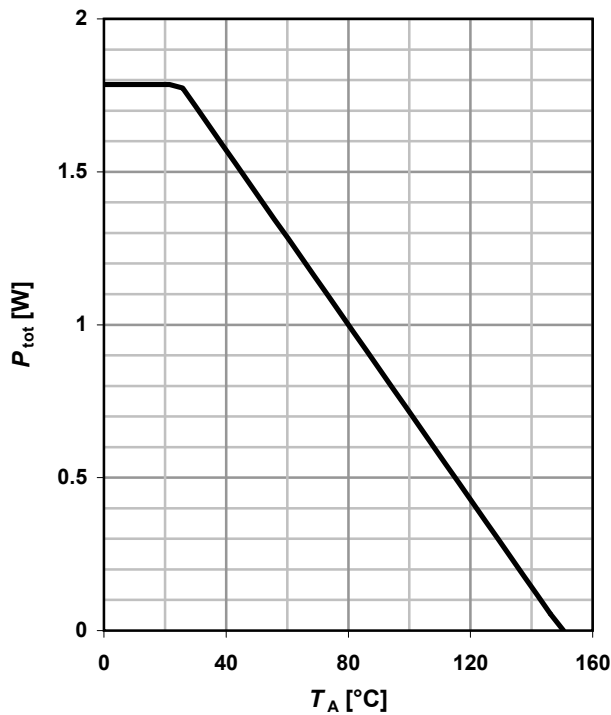
**Reverse Diode**

|                                  |               |  |   |       |      |    |
|----------------------------------|---------------|--|---|-------|------|----|
| Diode continuous forward current | $I_S$         | $T_A=25\text{ }^\circ\text{C}$   | - | -     | -1.9 | A  |
| Diode pulse current              | $I_{S,pulse}$ |  | - | -     | -7.6 |    |
| Diode forward voltage            | $V_{SD}$      | $V_{GS}=0\text{ V}$ , $I_F=1.9\text{ A}$ ,<br>$T_J=25\text{ }^\circ\text{C}$ | - | -0.84 | -1.1 | V  |
| Reverse recovery time            | $t_{rr}$      | $V_R=-30\text{ V}$ , $I_F= I_S $ ,<br>$di_F/dt=100\text{ A}/\mu\text{s}$     | - | 80    | 120  | ns |
| Reverse recovery charge          | $Q_{rr}$      |  | - | -125  | -190 |    |

<sup>2)</sup> See figure 16 for gate charge parameter definition

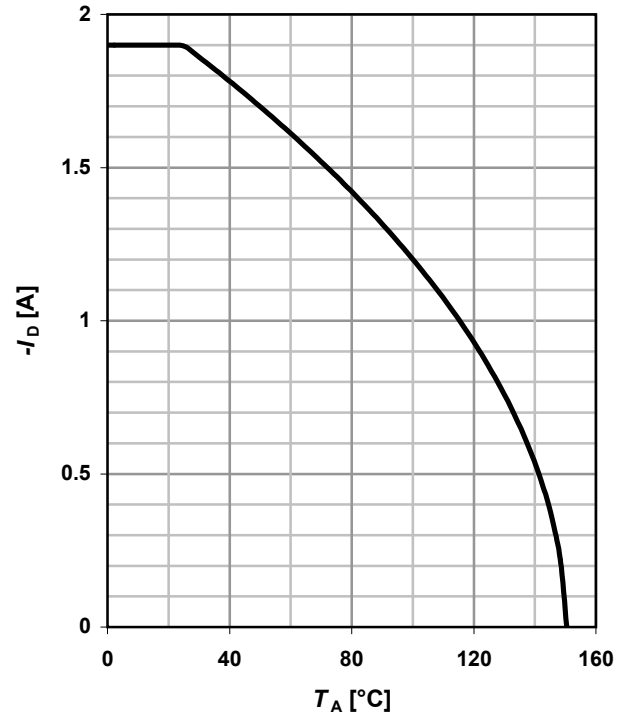
**1 Power dissipation**

$$P_{tot} = f(T_A)$$



**2 Drain current**

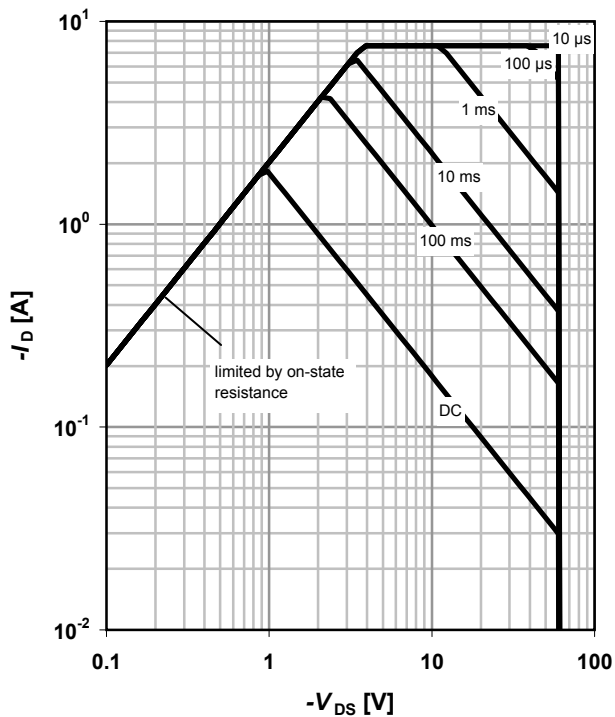
$$I_D = f(T_A); |V_{GS}| \geq 10 \text{ V}$$



**3 Safe operating area**

$$I_D = f(V_{DS}); T_A = 25 \text{ °C}^1; D = 0$$

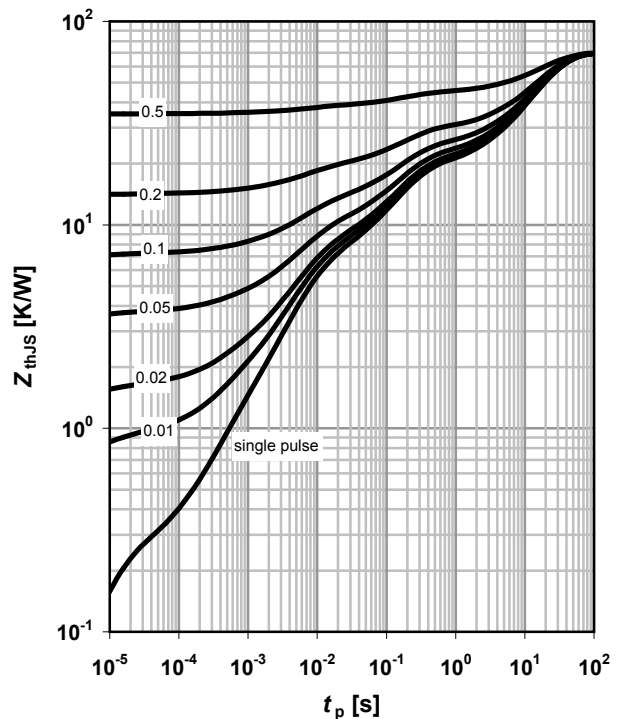
parameter:  $t_p$



**4 Max. transient thermal impedance**

$$Z_{thJA} = f(t_p)$$

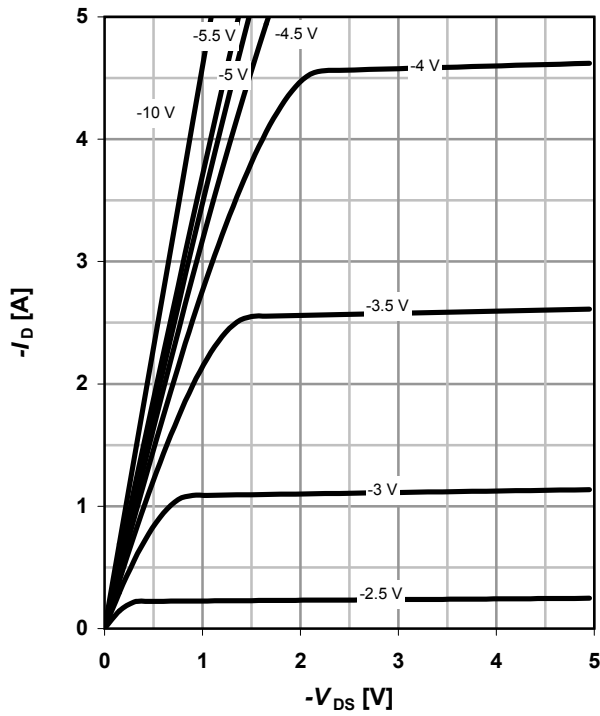
parameter:  $D = t_p/T$



**5 Typ. output characteristics**

$I_D = f(V_{DS}); T_j = 25\text{ }^\circ\text{C}$

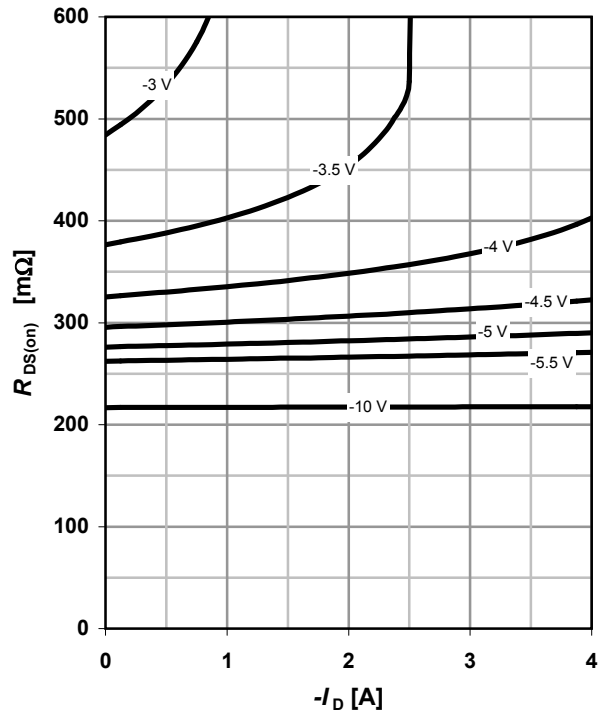
parameter:  $V_{GS}$



**6 Typ. drain-source on resistance**

$R_{DS(on)} = f(I_D); T_j = 25\text{ }^\circ\text{C}$

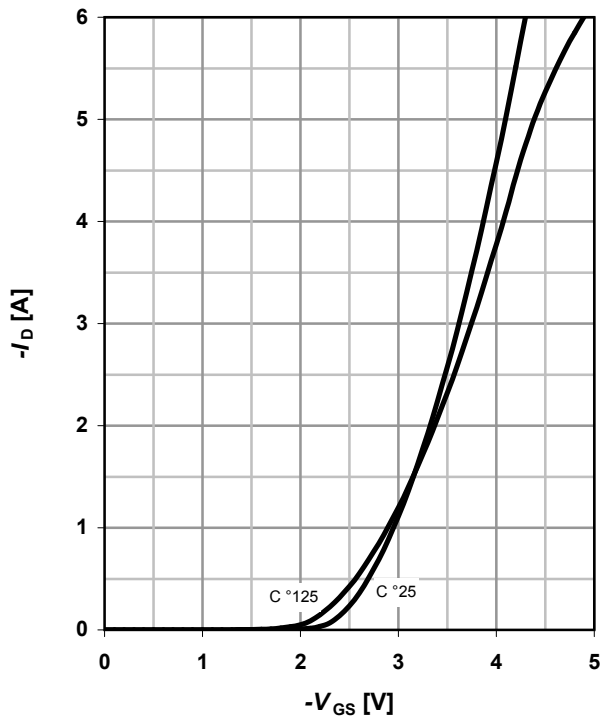
parameter:  $V_{GS}$



**7 Typ. transfer characteristics**

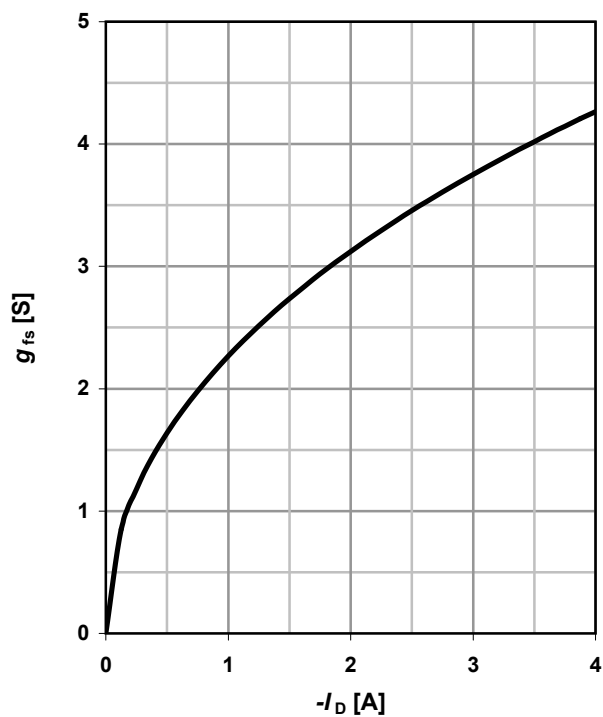
$I_D = f(V_{GS}); |V_{DS}| > 2|I_D|R_{DS(on)max}$

parameter:  $T_j$



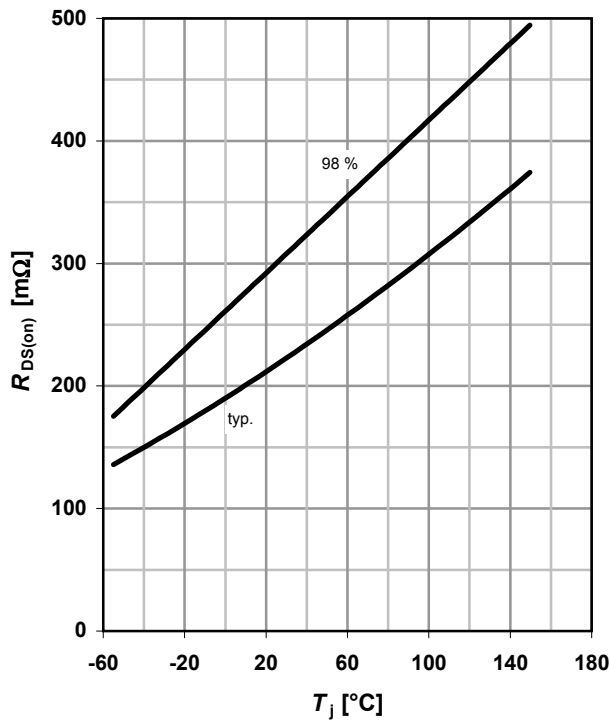
**8 Typ. forward transconductance**

$g_{fs} = f(I_D); T_j = 25\text{ }^\circ\text{C}$



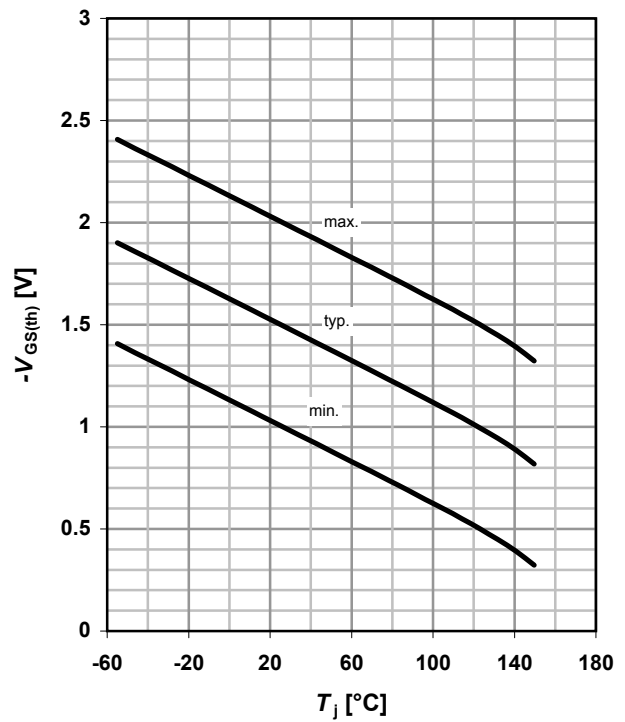
**9 Drain-source on-state resistance**

$R_{DS(on)}=f(T_j); I_D=-1.9\text{ A}; V_{GS}=-10\text{ V}$



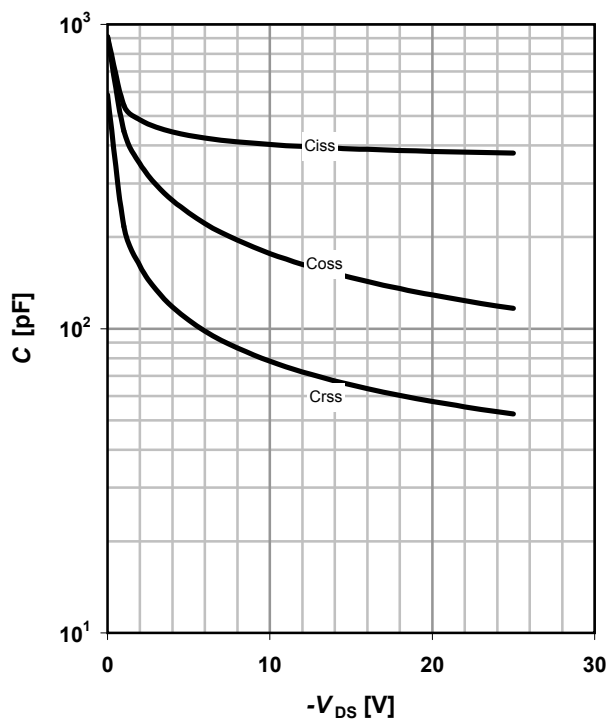
**10 Typ. gate threshold voltage**

$V_{GS(th)}=f(T_j); V_{GS}=V_{DS}; I_D=-460\ \mu\text{A}$



**11 Typ. capacitances**

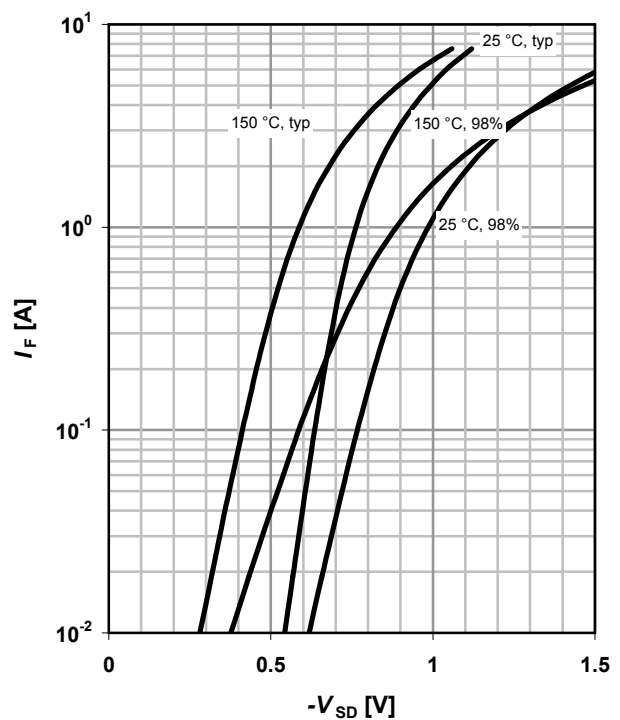
$C=f(V_{DS}); V_{GS}=0\text{ V}; f=1\text{ MHz}$



**12 Forward characteristics of reverse diode**

$I_F=f(V_{SD})$

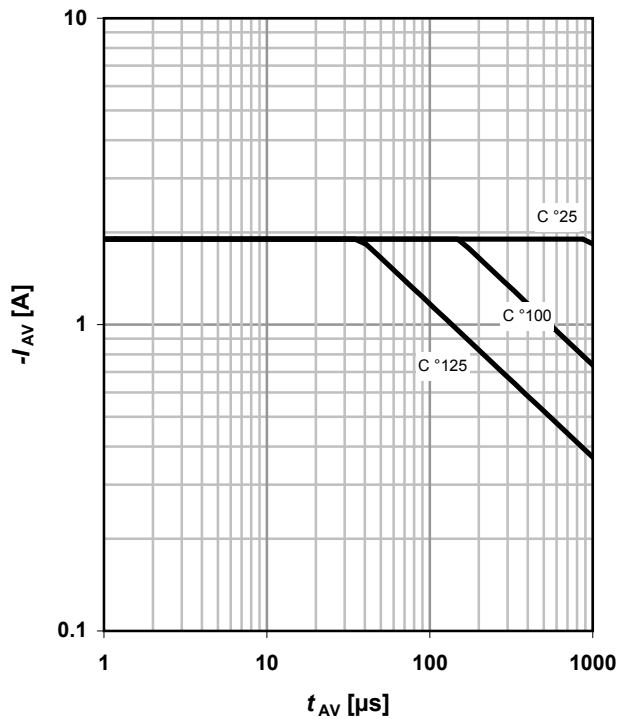
parameter:  $T_j$



### 13 Avalanche characteristics

$I_{AS}=f(t_{AV}); R_{GS}=25\ \Omega$

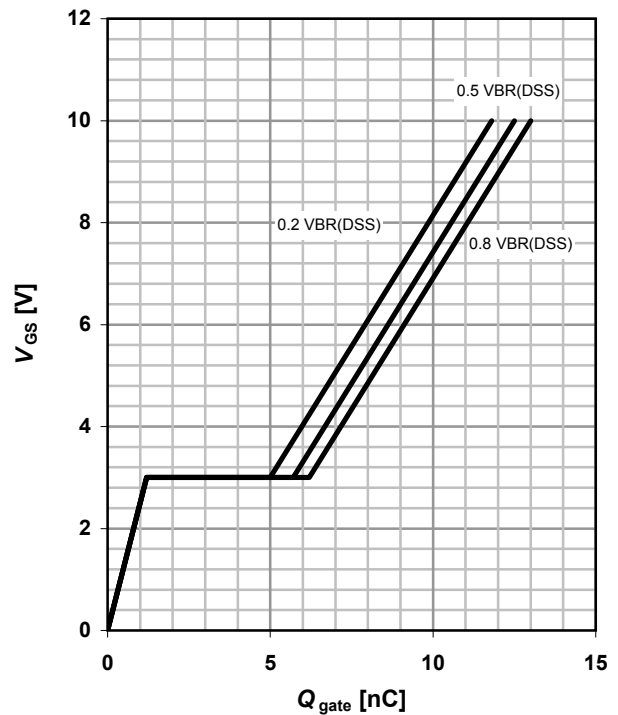
parameter:  $T_{j(start)}$



### 14 Typ. gate charge

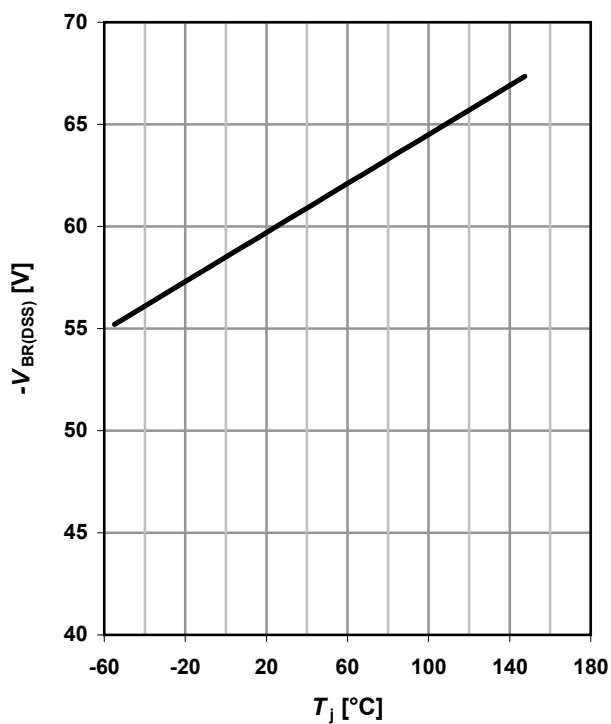
$V_{GS}=f(Q_{gate}); I_D=-1.9\ A\ pulsed$

parameter:  $V_{DD}$

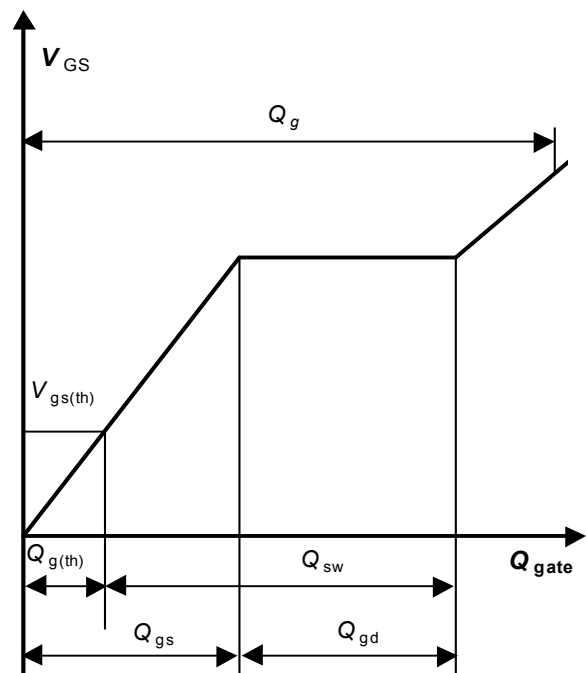


### 15 Drain-source breakdown voltage

$V_{BR(DSS)}=f(T_j); I_D=-1\ mA$

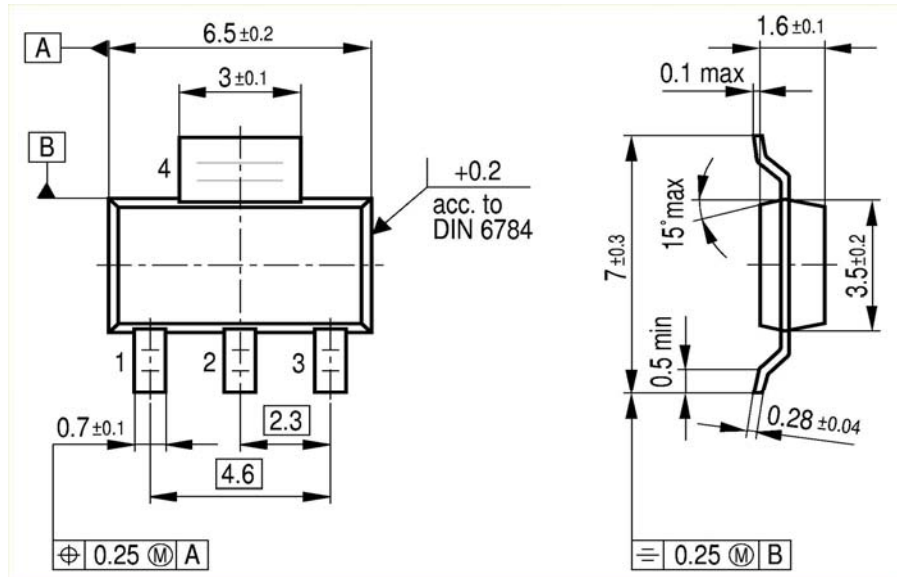


### 16 Gate charge waveforms

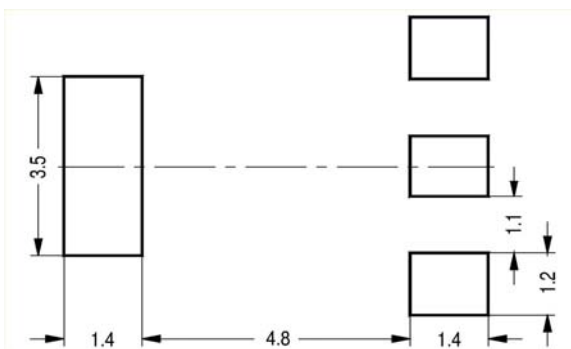


Package Outline

SOT-223: Outline

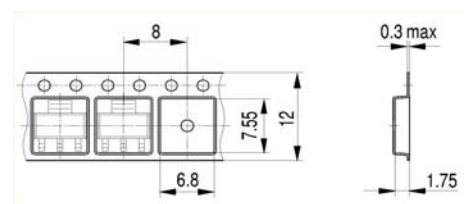


Footprint



Packaging

Tape



Dimensions in mm

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